TOSHIBA Bi-CMOS Integrated Circuit Silicon Monolithic

TB62747AFG, TB62747AFNG

16-Output Constant Current LED Driver

The TB62747 series is comprised of constant-current drivers designed for LEDs and LED panel displays.

The regulated current sources are designed to provide a constant current, which is adjustable through one external resistor.

The TB62747 series incorporates 16 channels of shift registers, latches, AND gates and constant-current outputs. Fabricated using the Bi-CMOS process, the TB62747 series satisfies the system requirement of high-speed data transmission.

It operates with a 3.3 or 5.0 V power supply.



SSOP24-P-300-1.00B: 0.29 g (typ.)

SSOP24-P-300-0.65A: 0.14 g (typ.)

Features

- 16-output built-in
- Output current setting range

: 1.5 to 35 mA @ V_{DD} = 3.3 V, V_O = 0.4 to 1.0 V

: 1.5 to 45 mA @
$$V_{DD}$$
 = 5.0 V, V_0 = 0.4 to 1.2 V

• Current accuracy (@ R_{EXT} = 1.2 k Ω , V₀ = 0.4 V, V_{DD} = 3.3 V, 5.0 V)

: Between outputs: ± 1.5 % (max)

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: Between devices: ± 1.5 % (max)
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- high-speed output switching : t_{wOE(L)} = 100 ns (min)
- Control data format : serial-in, parallel-out
- Input signal voltage level : 3.3 V and 5.0 V CMOS interfaces
 - (Schmitt trigger input)

• Serial data transfer rate : f_{SCK} = 25 MHz (max) @cascade connection

- Power supply voltages : V_{DD} = 3.0 V to 5.5 V
- Operation temperature range: Topr = -40 to 85 °C
- Output voltage $: V_0 = 26 V (max)$
- Power on reset (POR)
- Package : AFG type : SSOP24-P-300-1.00B : AFNG type : SSOP24-P-300-0.65A

Pin Assignment (top view)

*: VLED: LED power supply



TB62747AFG/AFNG

Note1: Short circuiting an output pin to a power supply pin (V_{DD} or V_{LED}*), or short-circuiting the R_{EXT} pin to the GND pin will likely exceed the rating, which in turn may result in smoldering and/or permanent damage. Please keep this in mind when determining the wiring layout for the power supply and GND pins.



Truth Table

SCK	SLAT	ŌĒ	SIN	OUT0 OUT7 OUT15 (Note1)	SOUT
	Н	L	Dn	Dn Dn - 7 Dn - 15	Dn - 15
	L	L	Dn + 1	No Change	Dn - 14
	Н	L	Dn + 2	Dn + 2 Dn - 5 Dn - 13	Dn - 13
$\overline{}$	— (Note2)	L	Dn + 3	Dn + 2 Dn - 5 Dn - 13	Dn - 13
$\overline{}$	— (Note2)	Н	Dn + 3	OFF	Dn - 13

Note1: When $\overline{\text{OUT0}}$ to $\overline{\text{OUT15}}$ output pins are set to "H" the respective output will be ON and when set to "L" the respective output will be OFF.

Note2: "—"is irrelevant to the truth table.

Timing Diagram



Note 1: The latch circuit is a leveled-latch circuit. Please note that it is not a triggered-latch circuit. Note 2: Keep the \overline{SLAT} pin is set to "L" to enable the latch circuit to hold data. In addition, when the \overline{SLAT} pin is set to "H" the latch circuit does not hold data. The data will instead pass onto output.

When the \overline{OE} pin is set to "L" the $\overline{OUT0}$ to $\overline{OUT15}$ output pins will go ON and OFF in response to the data. In addition, when the \overline{OE} pin is set to "H" all the output pins will be forced OFF regardless of the data.

Pin Functions

Pin No	Pin Name	I/O	Function
1	GND	_	The ground pin.
2	SIN	I	The serial data input pin.
3	SCK	Ι	The serial data transfer clock input pin. Data are shifted at the rising edge.
4	SLAT	I	The latch signal input pin. Data is saved at L level.
5	OUT0	0	A sink type constant current output pin.
6	OUT1	0	A sink type constant current output pin.
7	OUT2	0	A sink type constant current output pin.
8	OUT3	0	A sink type constant current output pin.
9	OUT4	0	A sink type constant current output pin.
10	OUT5	0	A sink type constant current output pin.
11	OUT6	0	A sink type constant current output pin.
12	OUT7	0	A sink type constant current output pin.
13	OUT8	0	A sink type constant current output pin.
14	OUT9	0	A sink type constant current output pin.
15	OUT10	0	A sink type constant current output pin.
16	OUT11	0	A sink type constant current output pin.
17	OUT12	0	A sink type constant current output pin.
18	OUT13	000	A sink type constant current output pin.
19	OUT14	0	A sink type constant current output pin.
20	OUT15	(7°)	A sink type constant current output pin.
21	OE		The constant current output enable signal input pin. During the "H" level, the output will be forced off.
22	SOUT	0	The serial data output pin.
23	REXT	> _ <	The constant current value setting resistor connection pin. Then a resistor connects to the ground. All output current is set to the same.
24	VDD	- (7	The power supply input pin.

Absolute Maximum Ratings (T_a = 25°C)

Characteristics	Symbol	Rating (Note1)	Unit
Power supply voltage	V _{DD}	-0.4 to 6.0	V
Output current	Ι _Ο	55	mA
Logic input voltage	V _{IN}	-0.3 to V _{DD} + 0.3 (Note2)	V
Output voltage	Vo	-0.3 to 26	V
Operating temperature	T _{opr}	-40 to 85	°C
Storage temperature	T _{stg}	-55 to 150	°C
Thermal resistance	Rth(j-a)	94 (AFG), 120 (AFNG) When mounted PCB (Note3)	°C/W
Power dissipation	PD	1.32 (AFG), 1.04 (AFNG) When mounted PCB (Note3), (Note4)	w

Note1: Voltage is ground referenced.

Note2: However, do not exceed 6 V.

Note3: PCB condition 76.2 mm x 114.3 mm x 1.6 mm, Cu 30 % (SEMI conforming, 4-Layer)

Note4: The power dissipation decreases the reciprocal of the saturated thermal resistance (1/ Rth(j-a)) for each One degree (°C) that the ambient temperature is exceeded from Ta = 25 °C.

Operating Conditions

DC Items (Unless otherwise specified, $V_{DD} = 3.0$ to 5.5 V, $T_a = -40^{\circ}$ C to 85°C)

Characteristics	Symbol	Test Conditions	Min	Тур.	Мах	Unit
Power supply voltage	V _{DD}	\bigcirc – \checkmark	3.0	_	5.5	V
Output voltage when ON	Vo (ON)	OUTn	0.4	_	4.0	V
High level logic input voltage	VIH	SIN,SCK, SLAT, OE	$0.7 \times V_{DD}$		V _{DD}	V
Low level logic input voltage	VIL	SIN,SCK, SLAT, OE	GND	_	0.3 × V _{DD}	V
High level SOUT output current	⊡Іон		_	_	-1	mA
Low level SOUT output current	IOL		_	_	1	mA
	I _{O1}	$\overline{\text{OUTn}}$, V_{DD} = 3.3 V, V_{O} = 0.4 to 1.0 V	1.5	_	35	m (
Constant current output	I _{O2}	$\overline{\text{OUTn}}$, V_{DD} = 5.0 V, V_{O} = 0.4 to 1.2 V	1.5	_	45	mA

AC Items (Unless otherwise specified, V_{DD} = 3.0 to 5.5 V, T_a = -40°C to 85°C)

Characteristics	Symbol	Test Circuits	Test Conditions	Min	Тур.	Max	Unit
Serial data transfer frequency	fscк	6	—	_	_	25	MHz
Hold time	tHOLD1	6		5			ns
	t _{HOLD2}	6		5			ns
Setup time	t _{SETUP1}	6		5			ns
Setup time	t _{SETUP2}	6	—	5	_	_	ns
Maximum clock rise time	t _r	6	(Note1)	_	_	500	ns
Maximum clock fall time	t _f	6	(Note1)	_	_	500	ns

Note1: If the device is connected in a cascade and the tr/tf of the clock waveform increases due to deceleration of the clock waveform, it may not be possible to achieve the timing required for data transfer. Please keep these timing conditions in mind when designing your application.

Electrical Characteristics (Unless otherwise specified, V_{DD} = 3.3 V, T_a = 25°C)

Characteristics	Symbol	Test Circuits	Test Conditions	Min	Тур.	Max	Unit
High level logic output voltage	V _{OH}	1	I _{OH} = -1 mA	V _{DD} - 0.4	_	_	V
Low level logic output voltage	V _{OL}	1	$I_{OL} = +1 \text{ mA}$	X	_	0.4	V
High level logic input current	I _{IH}	2	$V_{IN} = V_{DD}, \overline{OE}$, SIN, SCK	(-)	> _	1	μA
Low level logic input current	I _{IL}	3	$V_{IN} = GND, \overline{SLAT}, SIN, SCK$		_	-1	μA
	I _{DD1}	4	$V_0 = 25 V, R_{EXT} \neq OPEN,$ SCK = "L", $\overline{OE} = "H"$) –		1.0	mA
Power supply current	I _{DD2}	4	$R_{EXT} = 1.2 \text{ k}\Omega$, All output off		_	$\begin{array}{c cccc} - & - & \\ - & 0.4 \\ - & 1 \\ - & -1 \\ - & 1.0 \\ - & 4.0 \\ - & 8.0 \\ \hline 14 & - \\ \pm 1 & \pm 1.5 \\ \pm 1 & \pm 1.5 \\ - & 0.5 \\ \pm 1 & \pm 2 \\ \end{array}$	mA
	I _{DD3}	4	$R_{EXT} = 1.2 \text{ k}\Omega$, All output on	_	1	8.0	mA
Output current	IO	5	$V_{DD} = 3.3 \text{ V}, V_{O} = 0.4 \text{ V},$ R _{EXT} = 1.2 kΩ, OUT0 to OUT15	-~	14	> -	mA
Constant current error(Ch to Ch)	$\Delta I_{O(Ch)}$	5	$V_{DD} = 3.3 \text{ V}, V_O = 0.4 \text{ V},$ R _{EXT} = 1.2 kΩ, OUTO to OUT15	(\bigcirc)	+H	±1.5	%
Constant current error(IC to IC)	$\Delta I_{O(IC)}$	5				±1.5	%
Output OFF leak current	I _{OK}	5 <	$V_{DD} = 3.3 \text{ V}, V_{O} = 25 \text{ V},$ $R_{EXT} = 1.2 \text{ k}\Omega, \overline{\text{OUT0}} \text{ to } \overline{\text{OUT15}}$	\rightarrow	_	0.5	μA
Constant current power supply voltage regulation	%V _{DD}	5	$V_{DD} = 3.0$ to 3.6 V, $V_{O} = 0.4$ V, R _{EXT} = 1.2 k _Ω , <u>OUT0</u> to <u>OUT15</u>	Ι	±1	±2	%
Constant current output voltage regulation	%Vo	5	$V_{DD} = 3.3 V$, $V_{O} = 0.4$ to 3.0 V, R _{EXT} = 1.2 k Ω , $\overline{OUT0}$ to $\overline{OUT15}$	_	±1	_	%/V
Pull-up resistor	RUP	3	ŌĒ	250	500	800	kΩ
Pull-down resistor	RDOWN	2	SLAT	250	500	800	kΩ

Electrical Characteristics (Unless otherwise specified, $V_{DD} = 5.0 V$, $T_a = 25^{\circ}C$)

Characteristics	Symbol	Test Circuits	Test Conditions	Min	Тур.	Max	Unit
High level logic output voltage	V _{OH}	1	I _{OH} = -1 mA	V _{DD} - 0.4	_	_	V
Low level logic output voltage	V _{OL}	1	$I_{OL} = +1 \text{ mA}$	X	_	0.4	V
High level logic input current	I_{IH}	2	$V_{IN} = V_{DD}, \overline{OE}$, SIN, SCK		~ _	1	μA
Low level logic input current	I_{IL}	3	$V_{IN} = GND, \overline{SLAT}, SIN, SCK$		_	-1	μA
	I _{DD1}	4	$V_0 = 25 V, R_{EXT} = OPEN,$ SCK = "L", $\overline{OE} = "H"$) –		1.0	mA
Power supply current	I _{DD2}	4	$R_{EXT} = 1.2 \text{ k}\Omega$, All output off		-	4.5	mA
	I _{DD3}	4	$R_{EXT} = 1.2 \text{ k}\Omega$, All output on			8.0	mA
Output current	Ι _Ο	5	$V_{DD} = 5.0 \text{ V}, V_{O} = 0.4 \text{ V},$ $R_{EXT} = 1.2 \text{ k}\Omega, \overline{\text{OUT0}} \text{ to } \overline{\text{OUT15}}$		14	> -	mA
Constant current error(Ch to Ch)	$\Delta I_{O(Ch)}$	5	$V_{DD} = 5.0 \text{ V}, V_O = 0.4 \text{ V},$ R _{EXT} = 1.2 kΩ, OUTO to OUT15	(\bigcirc)	+H	±1.5	%
Constant current error(IC to IC)	$\Delta I_{O(IC)}$	5		PT/		±1.5	%
Output OFF leak current	I _{OK}	5 <	$V_{DD} = 5.0 \text{ V}, V_{O} = 25 \text{ V},$ $R_{EXT} = 1.2 \text{ k}\Omega, \overline{\text{OUT0}} \text{ to } \overline{\text{OUT15}}$	\rightarrow		0.5	μA
Constant current power supply voltage regulation	%V _{DD}	5	$V_{DD} = 4.5$ to 5.5 V, $V_0 = 0.4$ V, R _{EXT} = 1.2 k _Ω , <u>OUT0</u> to <u>OUT15</u>	I	±1	±2	%
Constant current output voltage regulation	%Vo	5	$V_{DD} = 5.0 \text{ V}, V_{O} = 0.4 \text{ to } 3.0 \text{ V}, R_{EXT} = 1.2 \text{ k}\Omega, \overline{\text{OUT0}} \text{ to } \overline{\text{OUT15}}$	_	±1	_	%/V
Pull-up resistor	RUP	3	OE	250	500	800	kΩ
Pull-down resistor	RDOWN	_2	SLAT	250	500	800	kΩ

Switching Characteristics (Unless otherwise specified, V_{DD} = 3.0 V, T_a = 25°C)

Characte	ristics	Symbol	Test Circuits	Test Conditions	Min	Тур.	Max	Unit		
	SCK- OUTO	t _{pLH1}	6	SLAT = "H", OE = "L"	_	20	300	ns		
	SLAT - OUTO	t _{pLH2}	6	$\overline{OE} = "L"$	\geq	20	300	ns		
	OE - OUTO	t _{pLH3}	6	SLAT = "H"	(-)	20	300	ns		
Propagation delay	SCK-SOUT	t _{pLH}	6	CL=10.5 pF	10	20	35	ns		
time	SCK- OUTO	t _{pHL1}	6	$\overline{\text{SLAT}}$ = "H", $\overline{\text{OE}}$ = "L"	\rightarrow	30	340	ns		
	SLAT - OUTO	t _{pHL2}	6	OE = "L"	<i>2</i> _	70	340	ns		
	OE - OUTO	t _{pHL3}	6	SLAT = "H"	_	70	340	ns		
	SCK-SOUT	t _{pHL}	6	CL=10.5 pF	10	20	35	ns		
Output rise time		t _{or}	6	10 to 90 % of voltage waveform	- <	20	90	ns		
Output fall time		t _{of}	6	90 to 10 % of voltage waveform	Ð	25	180	ns		
Enable pulse width		t _{wOE(L)}	6	$\overline{OE} = "L" (Note1)$	100	-0	_	ns		
Clock pulse width		t _{wSCK}	6	SCK = "H" or "L"	20	_		ns		
Latch pulse width		t _{wSLAT}	6	SLAT = "H"	_20	—	_	ns		
Note1: At the cond	Note1: At the condition of $t_{wOE(H)} = 250$ ns or more									

Switching Characteristics (Unless otherwise specified, V_{DD} = 5.5 V, T_a = 25°C)

Characte	Characteristics		Test Circuits	Test Conditions	Min	Тур.	Max	Unit
	SCK- OUTO	tpLH1	6	$\overline{\text{SLAT}}$ = "H", $\overline{\text{OE}}$ = "L"	_	20	300	ns
	SLAT - OUTO	tpLH2	6	OE = "L"		20	300	ns
		tрLH3	6	SLAT = "H"		20	300	ns
Propagation delay	SCK-SOUT	tpLH	6	CL=10.5 pF	10	20	35	ns
time	SCK-OUTO	t _{pHL1}	6	SLAT = "H", OE = "L"		30	340	ns
	SLAT - OUTO	t _{pHL2}	6	$\overline{OE} = "L"$		70	340	ns
<u></u>		t _{pHL3}	6	SLAT = "H"		70	340	ns
$\langle \rangle$	SCK-SOUT	t _{pHL}	6	CL=10.5 pF	10	20	35	ns
Output rise time		tor	6	10 to 90 % of voltage waveform	_	20	90	ns
Output fail time		tof	> 6	90 to 10 % of voltage waveform		25	180	ns
Enable pulse width		twoe(L)	6	$\overline{OE} = "L"$ (Note1)	100	_	_	ns
Clock pulse width		t _{wSCK}	6	SCK = "H" or "L"	20	_	_	ns
Latch pulse width		t _{wSLAT}	6	$\overline{\text{SLAT}}$ = "H"	20	_	_	ns

Note1: At the condition of $t_{wOE(H)} = 250$ ns or more

I/O Equivalent Circuits



Test Circuits

Test Circuit1: High level logic output voltage / Low level logic output voltage



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Test Circuit4: Power supply current



Test Circuit5: Constant current output / Output OFF leak current / Constant current error Constant current power supply voltage regulation / Constant current output voltage regulation



Test Circuit6: Switching Characteristics



Timing Waveforms

1. SCK, SIN, SOUT



Reference data

*This data is provided for reference only. Thorough evaluation and testing should be implemented when designing your application's mass production design.



Output Current – R_{EXT} Resistor

Reference data

*This data is provided for reference only. Thorough evaluation and testing should be implemented when designing your application's mass production design.



Output Current – Duty (LED turn-on rate)

Package Dimensions

SSOP24-P-300-1.00B

Unit : mm



Package Dimensions



Notes on Contents

1. Block Diagrams

Some of the functional blocks, circuits, or constants in the block diagram may be omitted or simplified for explanatory purposes.

2. Equivalent Circuits

The equivalent circuit diagrams may be simplified or some parts of them may be omitted for explanatory purposes.

3. Timing Charts

Timing charts may be simplified for explanatory purposes.

4. Application Circuits

The application circuits shown in this document are provided for reference purposes only. Thorough evaluation is required, especially at the mass production design stage. Toshiba does not grant any license to any industrial property rights by providing these examples of application circuits.

5. Test Circuits

Components in the test circuits are used only to obtain and confirm the device characteristics. These components and circuits are not guaranteed to prevent malfunction or failure from occurring in the application equipment.

IC Usage Considerations Notes on handling of ICs

- [1] The absolute maximum ratings of a semiconductor device are a set of ratings that must not be exceeded, even for a moment. Do not exceed any of these ratings. Exceeding the rating(s) may cause the device breakdown, damage or deterioration, and may result injury by explosion or combustion.
- [2] Use an appropriate power supply fuse to ensure that a large current does not continuously flow in case of over current and/or IC failure. The IC will fully break down when used under conditions that exceed its absolute maximum ratings, when the wiring is routed improperly or when an abnormal pulse noise occurs from the wiring or load, causing a large current to continuously flow and the breakdown can lead smoke or ignition. To minimize the effects of the flow of a large current in case of breakdown, appropriate settings, such as fuse capacity, fusing time and insertion circuit location, are required.
- [3] If your design includes an inductive load such as a motor coil, incorporate a protection circuit into the design to prevent device malfunction or breakdown caused by the current resulting from the inrush current at power ON or the negative current resulting from the back electromotive force at power OFF. IC breakdown may cause injury, smoke or ignition.

Use a stable power supply with ICs with built-in protection functions. If the power supply is unstable, the protection function may not operate, causing IC breakdown. IC breakdown may cause injury, smoke or ignition.

[4] Do not insert devices in the wrong orientation or incorrectly.

Make sure that the positive and negative terminals of power supplies are connected properly. Otherwise, the current or power consumption may exceed the absolute maximum rating, and exceeding the rating(s) may cause the device breakdown, damage or deterioration, and may result injury by

explosion or combustion

In addition, do not use any device that is applied the current with inserting in the wrong orientation or incorrectly even just one time.

[5] Carefully select external components (such as inputs and negative feedback capacitors) and load components (such as speakers), for example, power amp and regulator.

If there is a large amount of leakage current such as input or negative feedback condenser, the IC output DC voltage will increase. If this output voltage is connected to a speaker with low input withstand voltage, overcurrent or IC failure can cause smoke or ignition. (The over current can cause smoke or ignition from the IC itself.) In particular, please pay attention when using a Bridge Tied Load (BTL) connection type IC that inputs output DC voltage to a speaker directly.

Points to remember on handling of ICs

(1) Heat Radiation Design

In using an IC with large current flow such as power amp, regulator or driver, please design the device so that heat is appropriately radiated, not to exceed the specified junction temperature (T_J) at any time and condition. These ICs generate heat even during normal use. An inadequate IC heat radiation design can lead to decrease in IC life, deterioration of IC characteristics or IC breakdown. In addition, please design the device taking into considerate the effect of IC heat radiation with peripheral components.

(2) Back-EMF

When a motor rotates in the reverse direction, stops or slows down abruptly, a current flow back to the motor's power supply due to the effect of back-EMF. If the current sink capability of the power supply is small, the device's motor power supply and output pins might be exposed to conditions beyond maximum ratings. To avoid this problem, take the effect of back-EMF into consideration in system design.

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